

Simulation of Conical Refraction as a Tool for Polarization Metrology

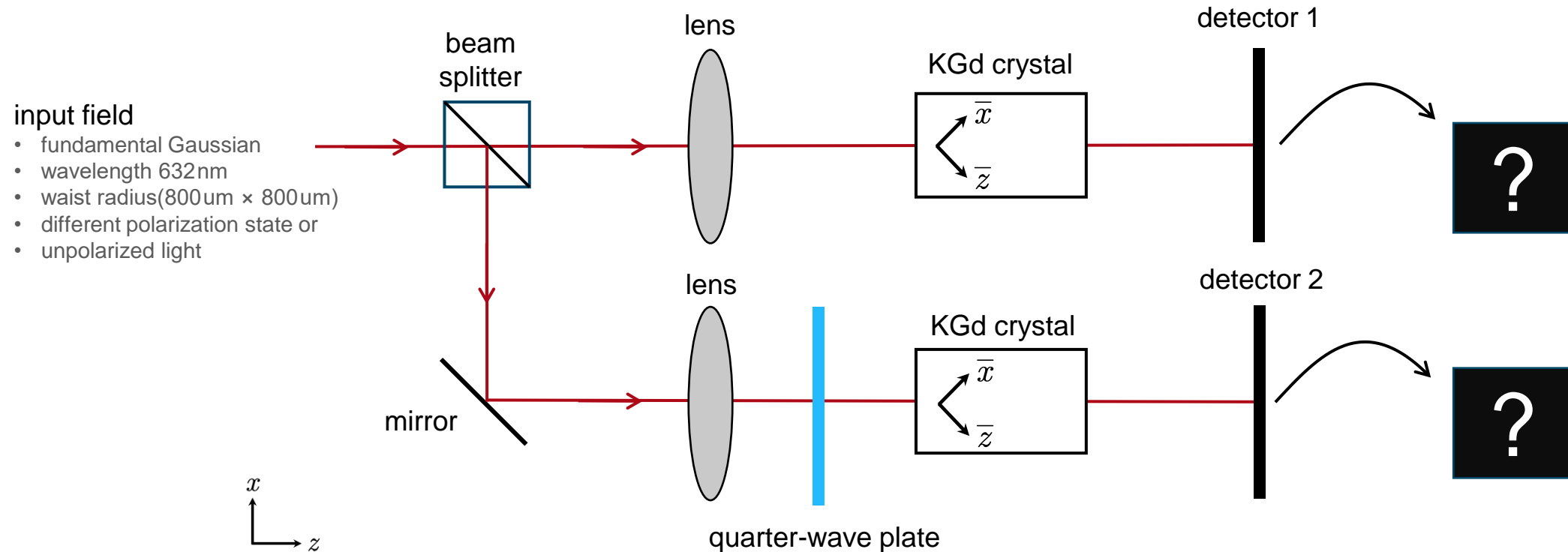
Abstract



Conical refraction is a well-known phenomenon occurring in biaxial crystals, whereby an input Gaussian beam is transformed into a light ring whose intensity distribution is related to the incoming polarization. Several applications have been developed based on this phenomenon, polarization metrology among them. In this use case, we demonstrate the design of a polarimeter with two biaxial crystals, one in each arm of the setup, utilizing the fast physical-optics software VirtualLab Fusion.

Modeling Task

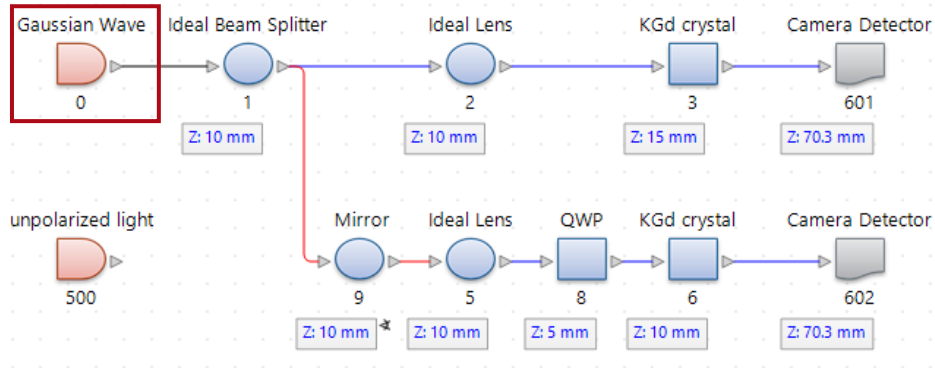
How to identify the polarization state of the incident field from the detected results?



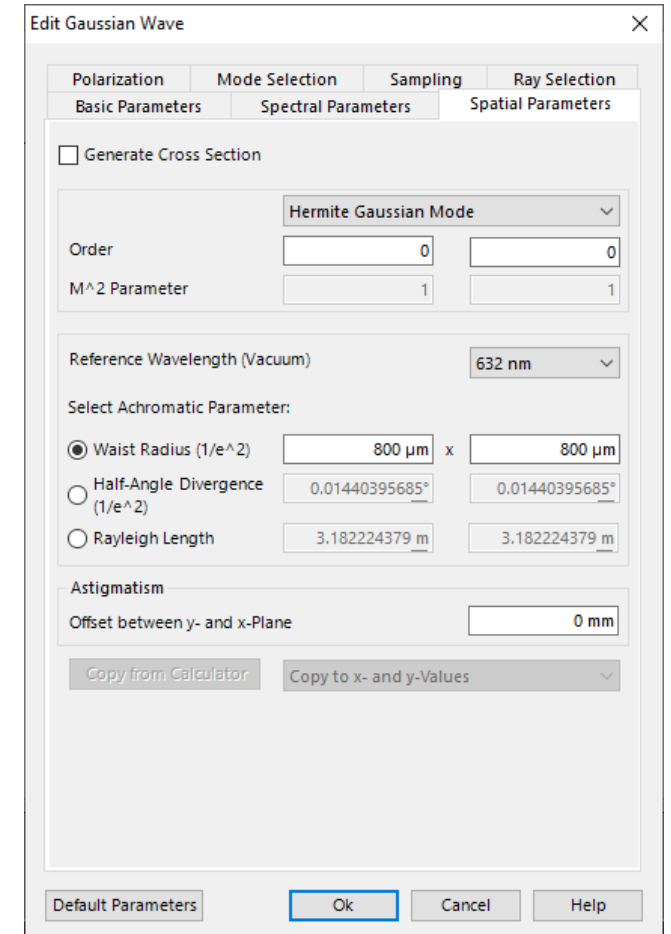
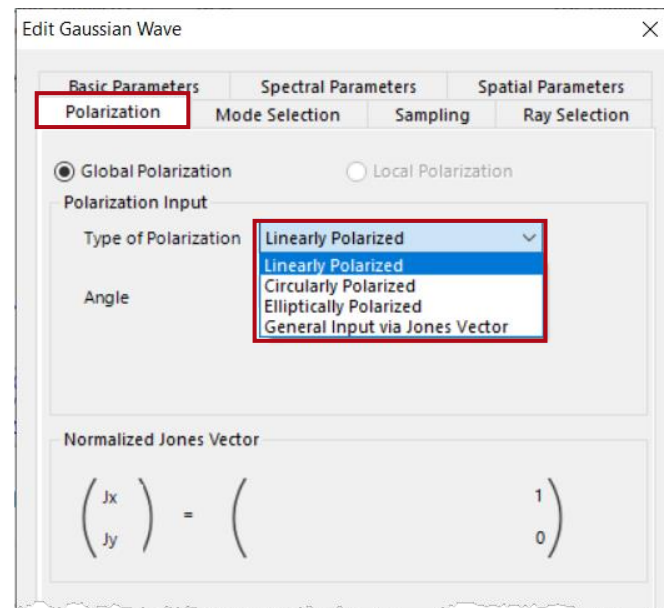
 Conical Refraction in Biaxial Crystals

Optical setup follow from Peinado, et al. Optics letters 38.20 (2013): 4100-4103.

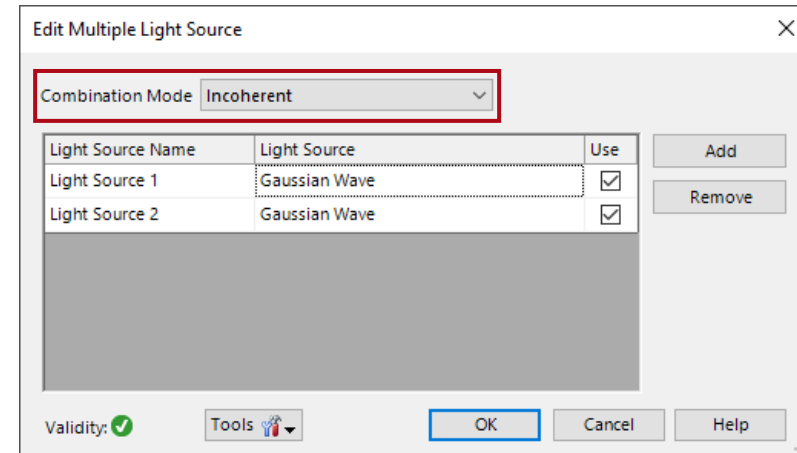
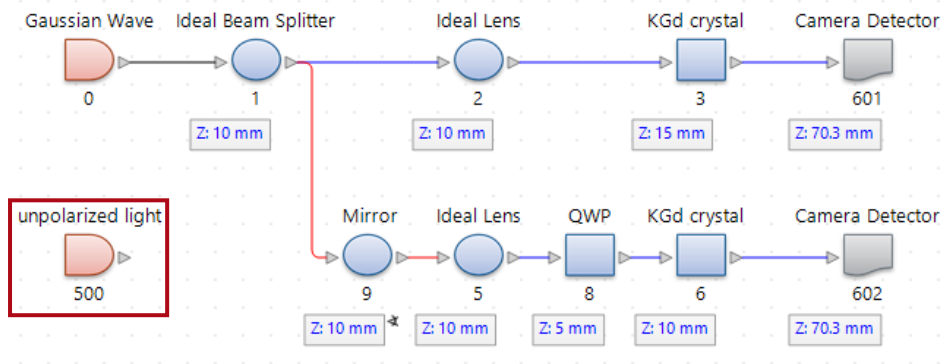
System Building Blocks – Polarized Light Source



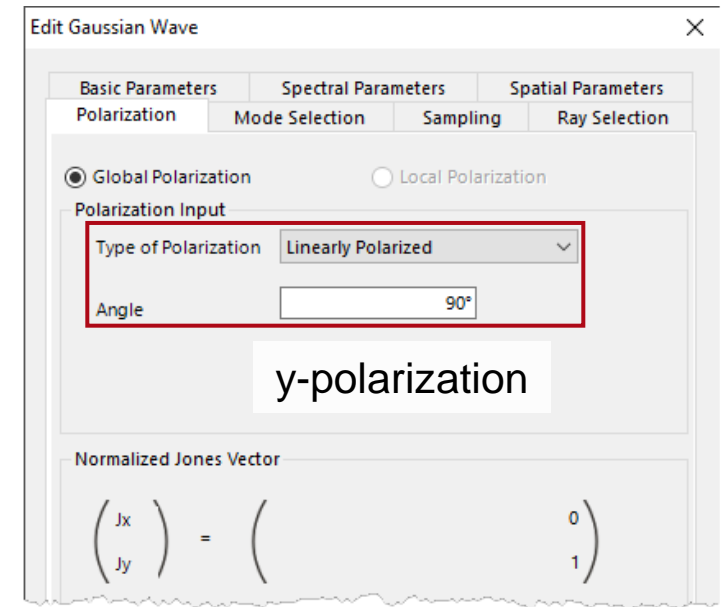
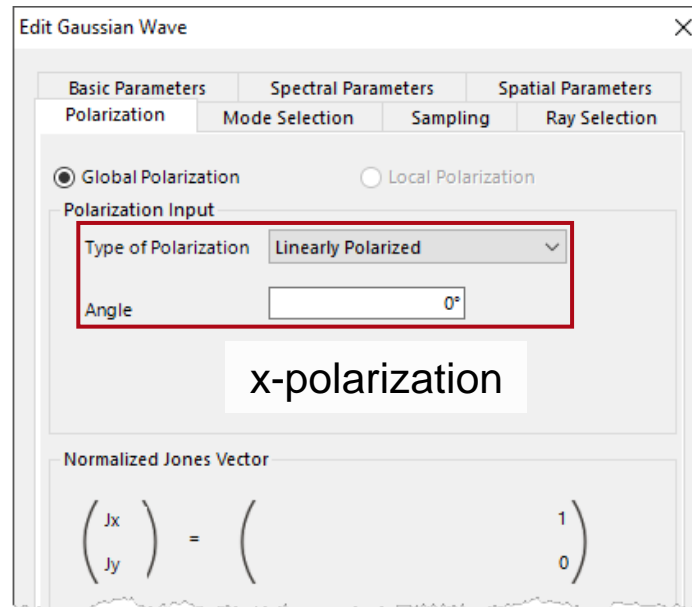
The input field with different (fully polarized) polarization states is modeled by a single *Gaussian Wave*.



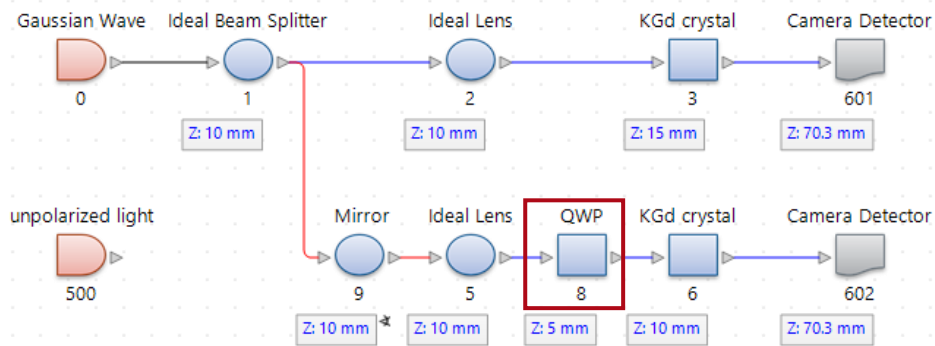
System Building Blocks – Unpolarized Light Source



- Unpolarized light gives, statistically, equal projections along any two states forming an orthogonal basis.
- Therefore, we use the *Multiple Light Source* with two Gaussian waves to model the average of the two orthogonal states, in an incoherent manner, to represent unpolarized light.



System Building Blocks – Quarter-Wave Plate



A quarter-wave plate (QWP) is applied in the second arm of the polarimeter and is modeled by the *Crystal Plate Component*. The thickness of the crystal plate can be calculated from the in-built calculator.

Edit Crystal Plate Component

Lateral Extent: 20 mm × 20 mm

Aperture: Yes No

Thickness: 904.9255441 nm [Waveplate Calculator](#)

Medium: Uniaxial Crystal QWP

Orientation: Y: 90°; Z: 45°

Coating: Name: No Coating

Calculation of Waveplate Thickness

Design Wavelength: 632 nm

Retardation: Quarter Wave (Wavelength Fraction: 0.25)

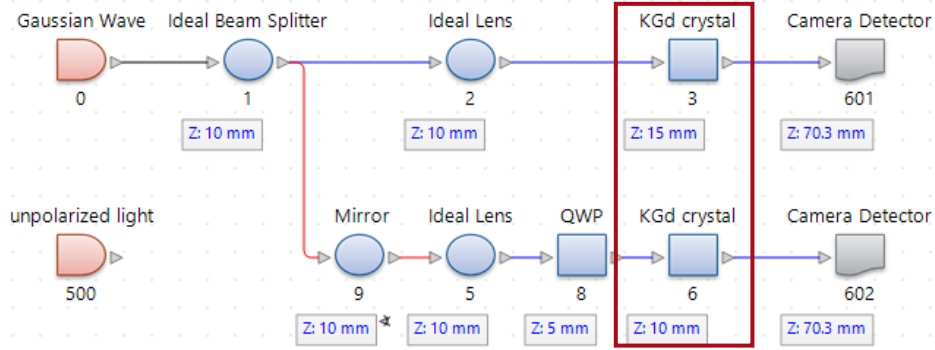
Medium: Uniaxial Crystal QWP

Use Minimum Thickness

Absolute Retardation: 0.25

Calculated Thickness: 904.9255441 nm

System Building Blocks – Biaxial KGd Crystal



Edit Biaxial Crystal

Material of Principal Index α
Name: KGd_n1@632nm
Catalog Material: [dropdown]
State of Matter: Gas or Vacuum

Material of Principal Index β
Name: KGd_n2@632nm
Catalog Material: [dropdown]
State of Matter: Gas or Vacuum

Material of Principal Index γ
Name: KGd_n3@632nm
Catalog Material: [dropdown]
State of Matter: Gas or Vacuum

Edit Crystal Plate Component

Lateral Extent: 20 mm x 20 mm

Aperture: Yes No

Thickness: 30 mm

Medium: Biaxial Crystal

Orientation: Y: 42.2°

Coating: No Coating

Set Orientation of Crystal

Orientation Definition Type: Sequence of Axis Rotation

Direction Definition	Angle / Axis	Value
1	Y-Axis Rotation	42.2°

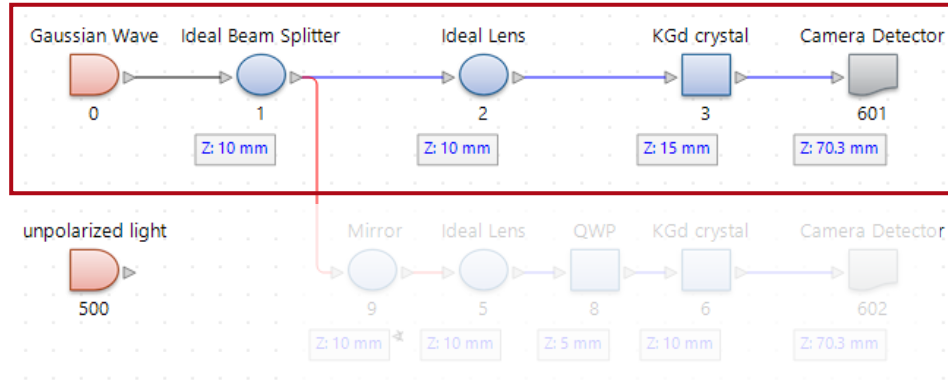
Biaxial Crystal

- thickness: 30mm
- refractive indices
 - $n_1 = 2.013$
 - $n_2 = 2.045$
 - $n_3 = 2.086$
- crystalline orientation
 - $\vec{x} = (0.74, 0, 0.67)$
 - $\vec{y} = (0, 1, 0)$
 - $\vec{z} = (-0.67, 0, 0.74)$

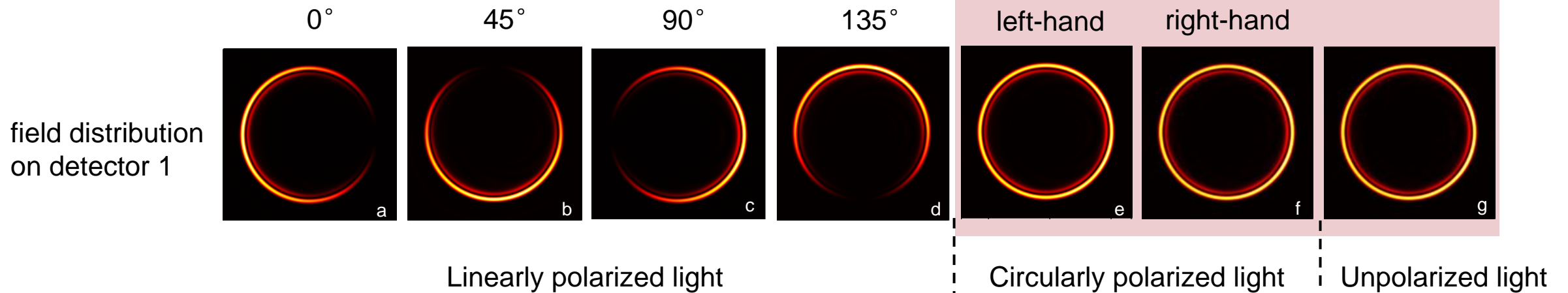
- Use a *Crystal Plate Component* to model the KGd crystal, then select *Biaxial Crystal* from the *Media* catalog and define the principal refractive indices.
- Set the crystalline orientation according to the reference, so that the input field will propagate along one of the optic axes of the crystal.

Parameters follow from C. F. Phelan et al., Opt. Express 17, 12891-12899 (2009)

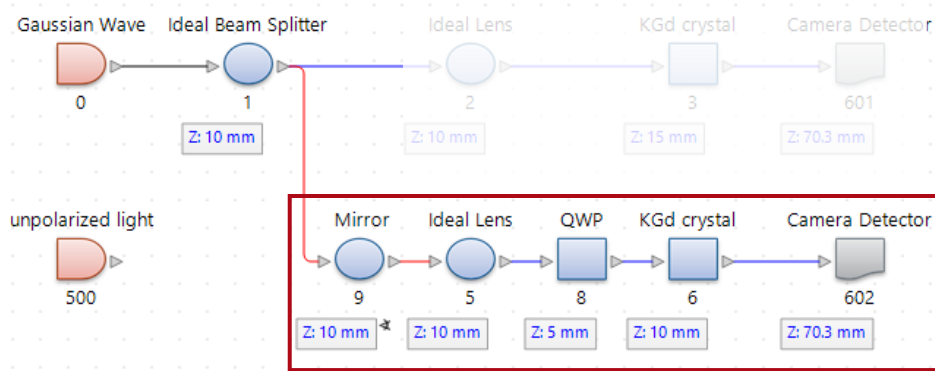
Simulation Results



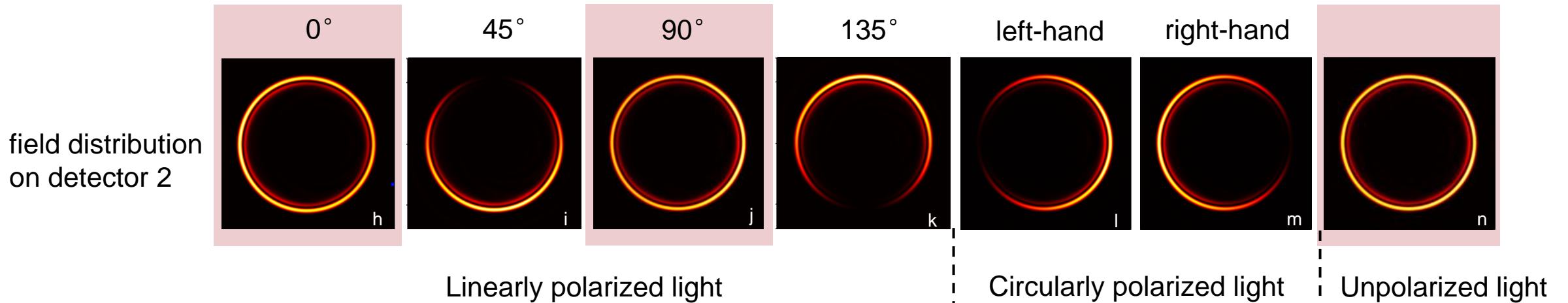
- Run the simulation and vary the polarization state of the input source (linearly polarized, circularly polarized, and unpolarized).
- If only arm 1 is used, there is no distinction between right and left circularly polarized light, and unpolarized light. [see figs. e-g].



Simulation Results

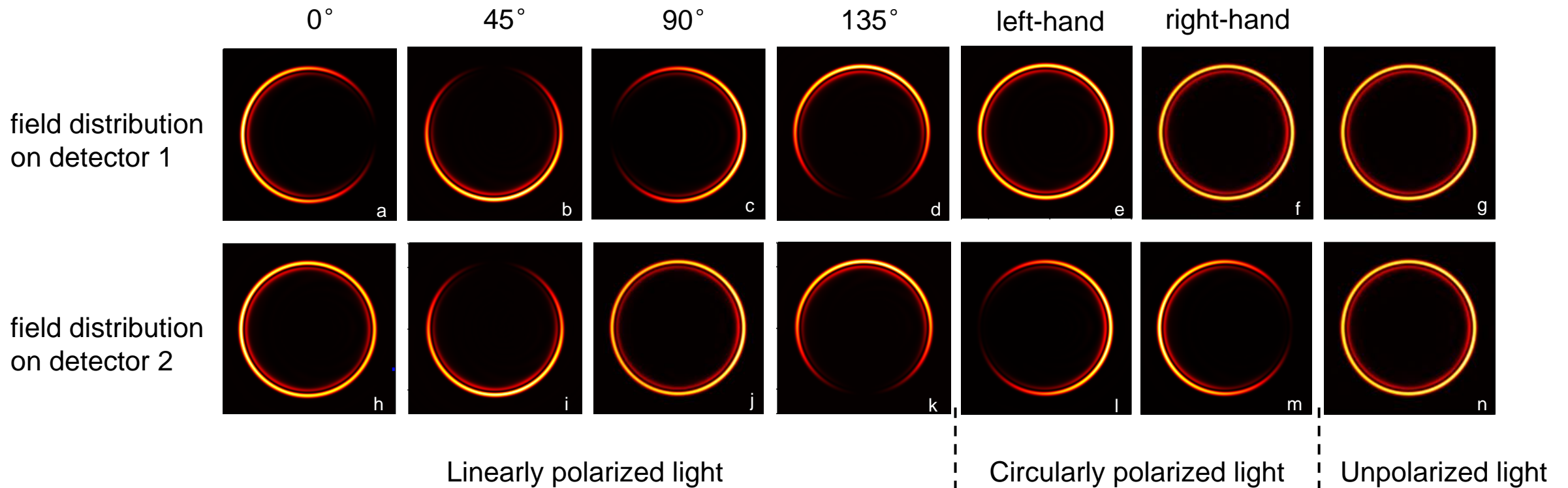


- If the angle between the orientation of the QWP and the input polarization direction is 45° , the linearly polarized beam will change into a circularly polarized one, and vice versa.
- As a result, arm 2 cannot distinguish between linearly polarized light at 0° , 90° and unpolarized light. [see figs. h, j, n].

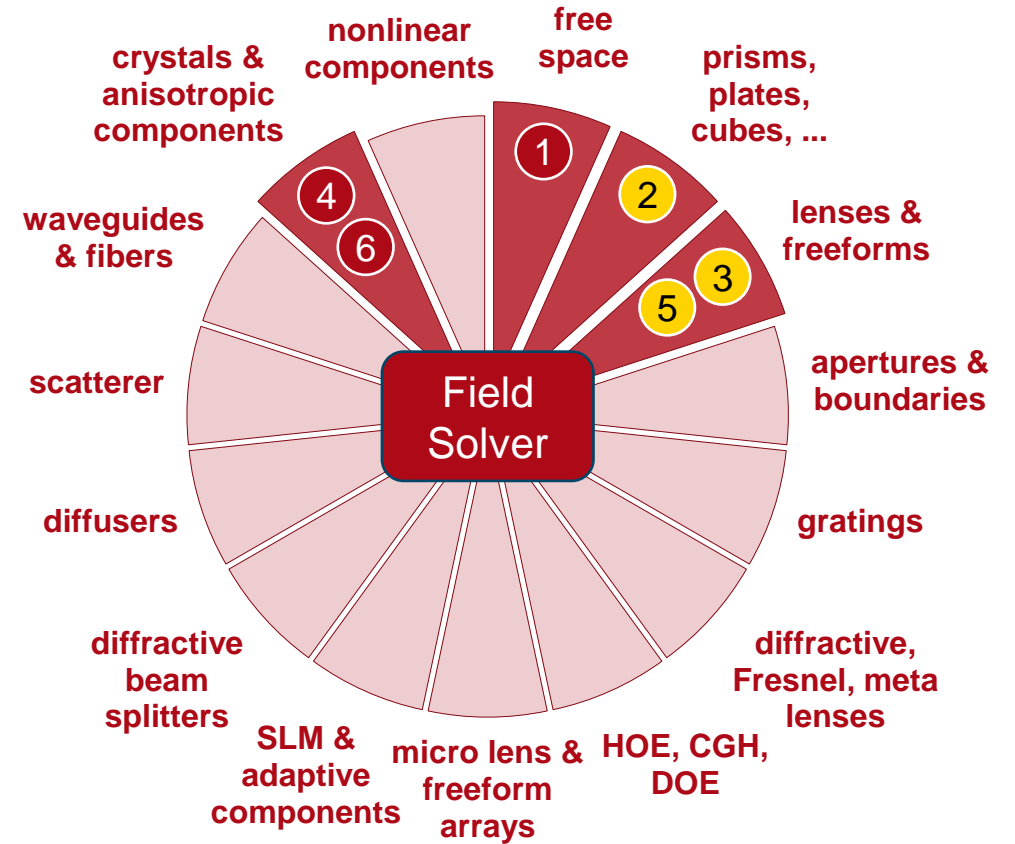
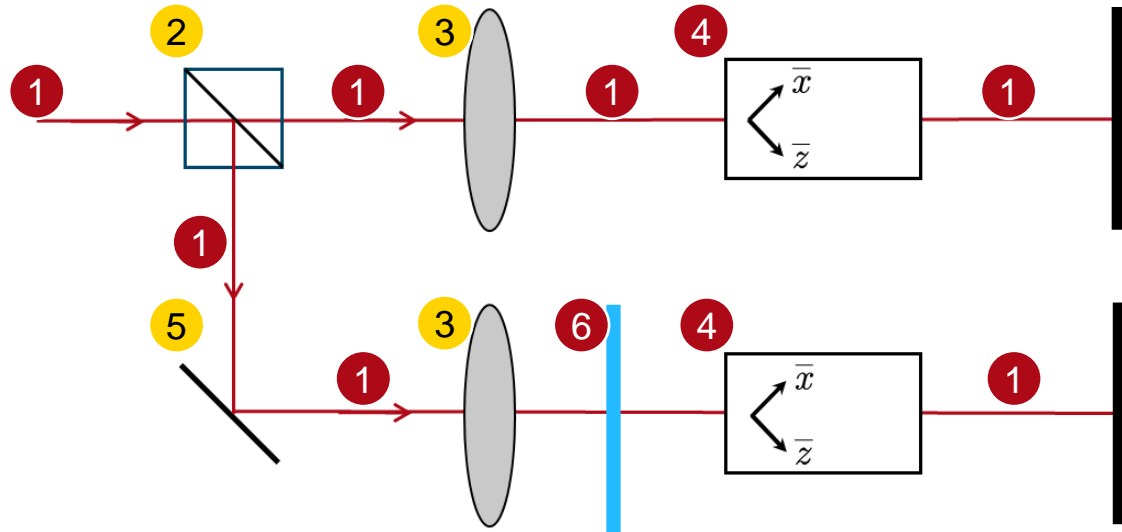


Simulation Results

By comparing the field distribution on the detectors of each of the two arms, we can distinguish each state of input field polarization, including unpolarized light.



VirtualLab Fusion Technologies



idealized component

Document Information

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